

**Search Notes**

Application/Control No.

10/521,893

Examiner

Ren L. Yan

Applicant(s)/Patent under  
Reexamination

STEENKAMER ET AL.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
101	119 120	4/10/07	RY
	123		
	124		
	155-157		
	167-169		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR